

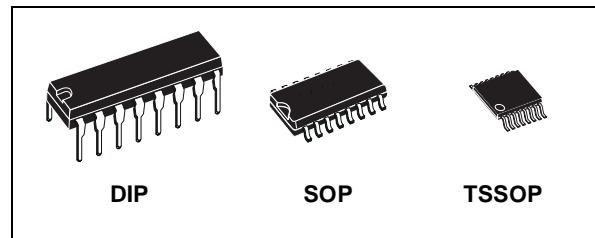
### 3 TO 8 LINE DECODER LATCH

- HIGH SPEED:  
 $t_{PD} = 16\text{ns}$  (TYP.) at  $V_{CC} = 6\text{V}$
- LOW POWER DISSIPATION:  
 $I_{CC} = 4\mu\text{A}$ (MAX.) at  $T_A=25^\circ\text{C}$
- HIGH NOISE IMMUNITY:  
 $V_{NIH} = V_{NIL} = 28\%$   $V_{CC}$  (MIN.)
- SYMMETRICAL OUTPUT IMPEDANCE:  
 $|I_{OHI}| = I_{OL} = 4\text{mA}$  (MIN)
- BALANCED PROPAGATION DELAYS:  
 $t_{PLH} \approx t_{PHL}$
- WIDE OPERATING VOLTAGE RANGE:  
 $V_{CC}$  (OPR) = 2V to 6V
- PIN AND FUNCTION COMPATIBLE WITH  
74 SERIES 237

#### DESCRIPTION

The M74HC237 is an high speed CMOS 3 TO 8 LINE DECODER fabricated with silicon gate C<sup>2</sup>MOS technology.

When  $\bar{GL}$  goes from low to high, the address present at the select inputs (A, B, C) is stored in the latches. As long as  $\bar{GL}$  remains high no address changes will be recognized. Output enable controls, G1 and G2 control the state of the outputs independently of the select or

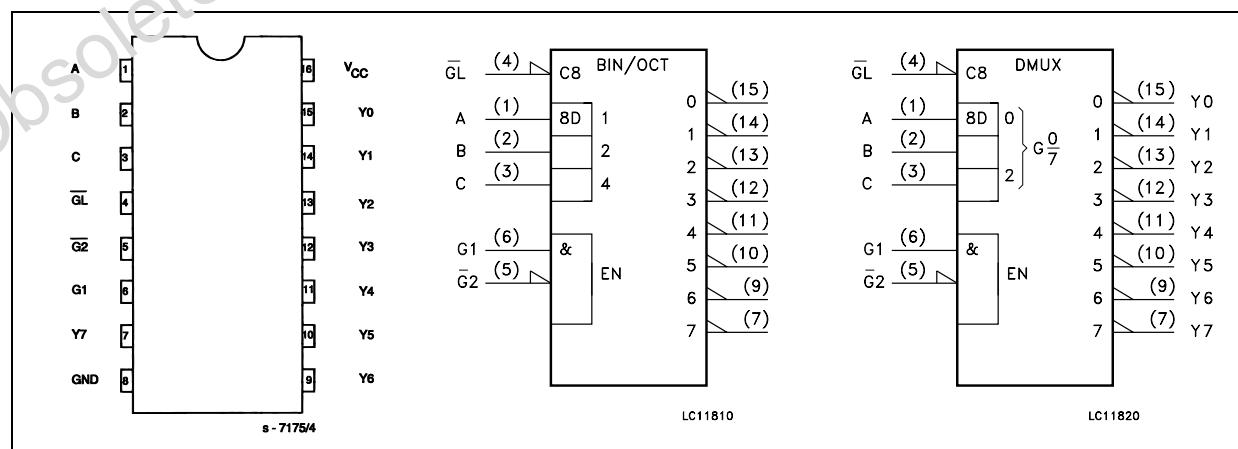


#### ORDER CODES

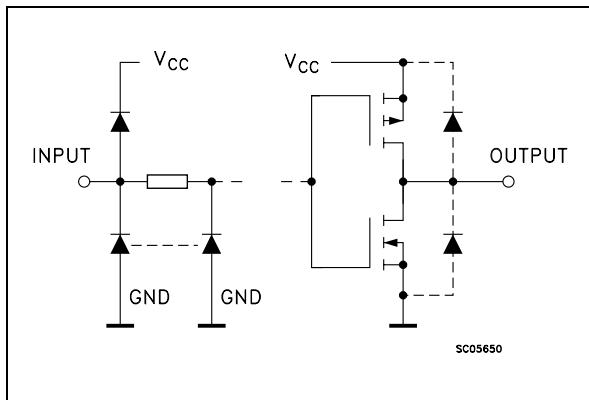
PACKAGE	TUBE	1 & R
DIP	M74HC237B1R	
SOP	M74HC237M1R	M74HC237RM13TR
TSSOP		M74HC237TTR

latch-enable inputs. All of the outputs are low unless G1 is high and G2 is low. The M74HC237 is ideally suited for the implementation of glitch-free decoders in stored-address applications in bus oriented systems. All inputs are equipped with protection circuits against static discharge and transient excess voltage.

#### PIN CONNECTION AND IEC LOGIC SYMBOLS



**INPUT AND OUTPUT EQUIVALENT CIRCUIT**



**PIN DESCRIPTION**

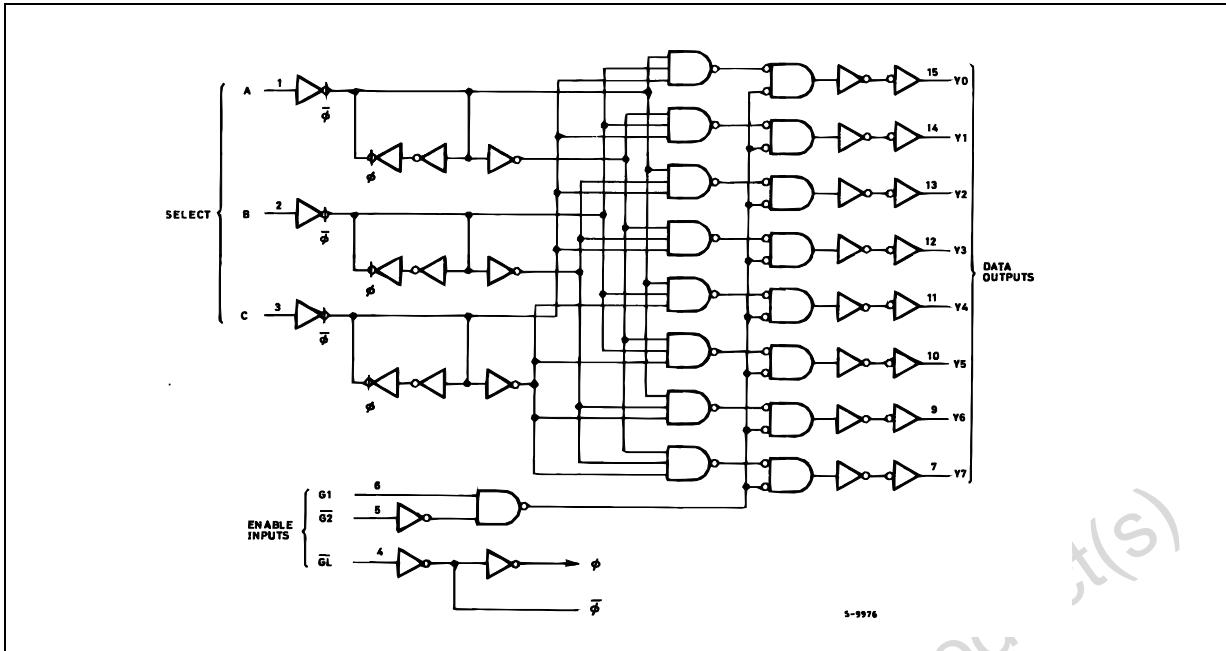
PIN No	SYMBOL	NAME AND FUNCTION
1, 2, 3	A, B, C	Data Inputs
4	GL	Latch Enable Input
5	G2	Data Enable Input (Active LOW)
6	G1	Data Enable Input (Active HIGH)
15, 14, 13, 12, 11, 10, 9, 7	Y0 to Y7	Decoder Outputs
8	GND	Ground (0V)
16	V <sub>CC</sub>	Positive Supply Voltage

**TRUTH TABLE**

INPUTS						OUTPUTS							
ENABLE			SELECT			Y0	Y1	Y2	Y3	Y4	Y5	Y6	Y7
GL	G2	G1	C	B	A	Y0	Y1	Y2	Y3	Y4	Y5	Y6	Y7
X	X	L	X	X	X	L	L	L	L	L	L	L	L
X	H	X	X	X	X	L	L	L	L	L	L	L	L
L	L	H	L	L	L	H	L	L	L	L	L	L	L
L	L	H	L	L	H	L	H	L	L	L	L	L	L
L	L	H	L	H	L	L	L	H	L	L	L	L	L
L	L	H	L	H	H	L	L	L	H	L	L	L	L
L	L	H	H	L	L	L	L	L	L	H	L	L	L
L	L	H	H	L	H	L	L	L	L	L	H	L	L
L	L	H	H	H	H	L	L	L	L	L	L	L	H
H	L	H	X	X	X	Outputs corresponding to stored address H: all others L							

X : Don't Care

## LOGIC DIAGRAM



This logic diagram has not been used to estimate propagation delays

## ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
$V_{CC}$	Supply Voltage	-0.5 to +7	V
$V_I$	DC Input Voltage	-0.5 to $V_{CC} + 0.5$	V
$V_O$	DC Output Voltage	-0.5 to $V_{CC} + 0.5$	V
$I_{IK}$	DC Input Diode Current	$\pm 20$	mA
$I_{OK}$	DC Output Diode Current	$\pm 20$	mA
$I_O$	DC Output Current	$\pm 25$	mA
$I_{CC}$ or $I_{GND}$	DC $V_{CC}$ or Ground Current	$\pm 50$	mA
$P_D$	Power Dissipation	500(*)	mW
$T_{stg}$	Storage Temperature	-65 to +150	°C
$T_L$	Lead Temperature (10 sec)	300	°C

Absolute Maximum Ratings are those values beyond which damage to the device may occur. Functional operation under these conditions is not implied.

(\*) 500mW at 65 °C; derate to 300mW by 10mW/°C from 65°C to 85°C

## RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Value	Unit
$V_{CC}$	Supply Voltage	2 to 6	V
$V_I$	Input Voltage	0 to $V_{CC}$	V
$V_O$	Output Voltage	0 to $V_{CC}$	V
$T_{op}$	Operating Temperature	-55 to 125	°C
$t_r, t_f$	Input Rise and Fall Time	$V_{CC} = 2.0V$	ns
		$V_{CC} = 4.5V$	ns
		$V_{CC} = 6.0V$	ns

## DC SPECIFICATIONS

Symbol	Parameter	Test Condition		Value						Unit	
		$V_{CC}$ (V)		$T_A = 25^\circ C$			$-40 \text{ to } 85^\circ C$		$-55 \text{ to } 125^\circ C$		
				Min.	Typ.	Max.	Min.	Max.	Min.	Max.	
$V_{IH}$	High Level Input Voltage	2.0		1.5			1.5		1.5		V
		4.5		3.15			3.15		3.15		
		6.0		4.2			4.2		4.2		
$V_{IL}$	Low Level Input Voltage	2.0			0.5		0.5		0.5		V
		4.5			1.35		1.35		1.35		
		6.0			1.8		1.8		1.8		
$V_{OH}$	High Level Output Voltage	2.0	$I_O=-20 \mu A$	1.9	2.0		1.9		1.9		V
		4.5	$I_O=-20 \mu A$	4.4	4.5		4.4		4.4		
		6.0	$I_O=-20 \mu A$	5.9	6.0		5.9		5.9		
		4.5	$I_O=-4.0 mA$	4.18	4.31		4.13		4.10		
		6.0	$I_O=-5.2 mA$	5.68	5.8		5.63		5.60		
$V_{OL}$	Low Level Output Voltage	2.0	$I_O=20 \mu A$		0.0	0.1		0.1		0.1	V
		4.5	$I_O=20 \mu A$		0.0	0.1		0.1		0.1	
		6.0	$I_O=20 \mu A$		0.0	0.1		0.1		0.1	
		4.5	$I_O=4.0 mA$		0.17	0.26		0.33		0.40	
		6.0	$I_O=5.2 mA$		0.18	0.26		0.33		0.40	
$I_I$	Input Leakage Current	6.0	$V_I = V_{CC} \text{ or GND}$			$\pm 0.1$		$\pm 1$		$\pm 1$	$\mu A$
$I_{CC}$	Quiescent Supply Current	6.0	$V_I = V_{CC} \text{ or GND}$			4		40		80	$\mu A$

AC ELECTRICAL CHARACTERISTICS ( $C_L = 50 \text{ pF}$ , Input  $t_r = t_f = 6\text{ns}$ )

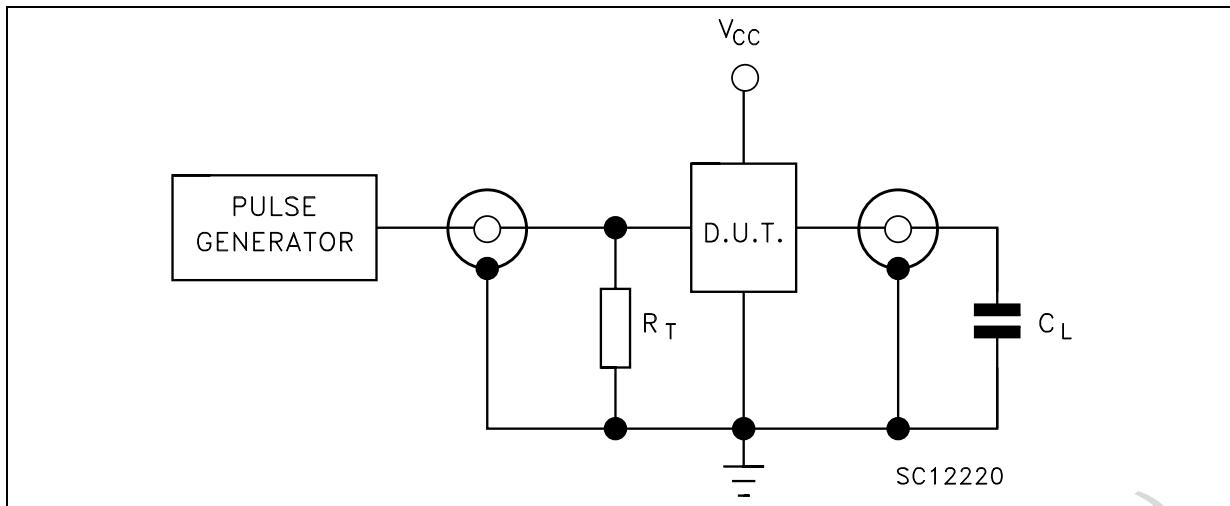
Symbol	Parameter	Test Condition		Value						Unit	
		$V_{CC}$ (V)		$T_A = 25^\circ\text{C}$			$-40 \text{ to } 85^\circ\text{C}$		$-55 \text{ to } 125^\circ\text{C}$		
				Min.	Typ.	Max.	Min.	Max.	Min.		
$t_{TLH}$ $t_{THL}$	Output Transition Time	2.0			30	75		95		110	ns
		4.5			8	15		19		22	
		6.0			7	13		16		19	
$t_{PLH}$ $t_{PHL}$	Propagation Delay Time (A, B, C - Y)	2.0			60	180		225		270	ns
		4.5			19	36		45		54	
		6.0			16	31		38		46	
$t_{PLH}$ $t_{PHL}$	Propagation Delay Time (G1 - Y)	2.0			45	140		175		210	ns
		4.5			15	28		35		42	
		6.0			13	24		30		36	
$t_{PLH}$ $t_{PHL}$	Propagation Delay Time (G2 - Y)	2.0			45	140		175		210	ns
		4.5			15	28		35		42	
		6.0			13	24		30		36	
$t_{PLH}$ $t_{PHL}$	Propagation Delay Time (GL - Y)	2.0			65	190		240		285	ns
		4.5			21	38		48		57	
		6.0			18	32		41		48	
$t_{W(L)}$	Minimum Pulse Width (GL)	2.0			10	75		95		110	ns
		4.5			6	15		19		22	
		6.0			6	13		16		19	
$t_s$	Minimum Set-up Time (A, B, C - GL)	2.0			12	50		65		75	ns
		4.5			3	10		13		15	
		6.0			2	9		11		13	
$t_h$	Minimum Hold Time (A, B, C - GL)	2.0			25			30		40	ns
		4.5			5			6		8	
		6.0			5			5		7	

## CAPACITIVE CHARACTERISTICS

Symbol	Parameter	Test Condition		Value						Unit	
		$V_{CC}$ (V)		$T_A = 25^\circ\text{C}$			$-40 \text{ to } 85^\circ\text{C}$		$-55 \text{ to } 125^\circ\text{C}$		
				Min.	Typ.	Max.	Min.	Max.	Min.		
$C_{IN}$	Input Capacitance	5.0			5	10		10		10	pF
$C_{PD}$	Power Dissipation Capacitance (note 1)	5.0			52						pF

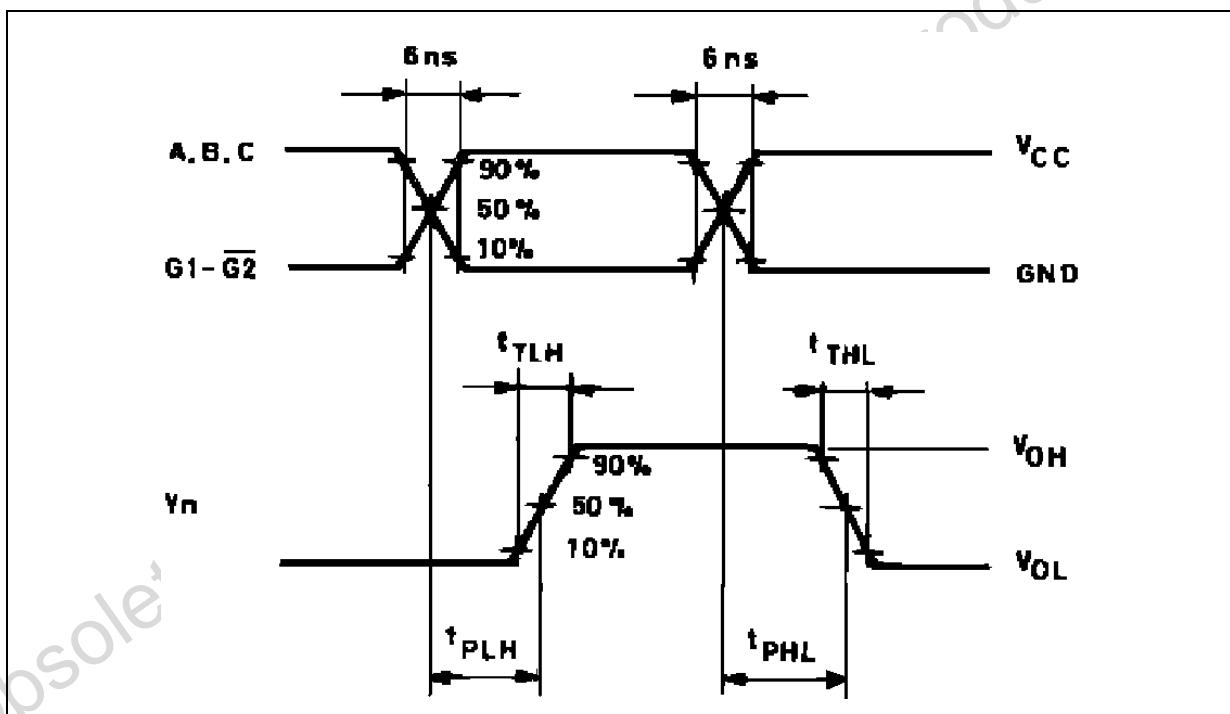
1)  $C_{PD}$  is defined as the value of the IC's internal equivalent capacitance which is calculated from the operating current consumption without load.

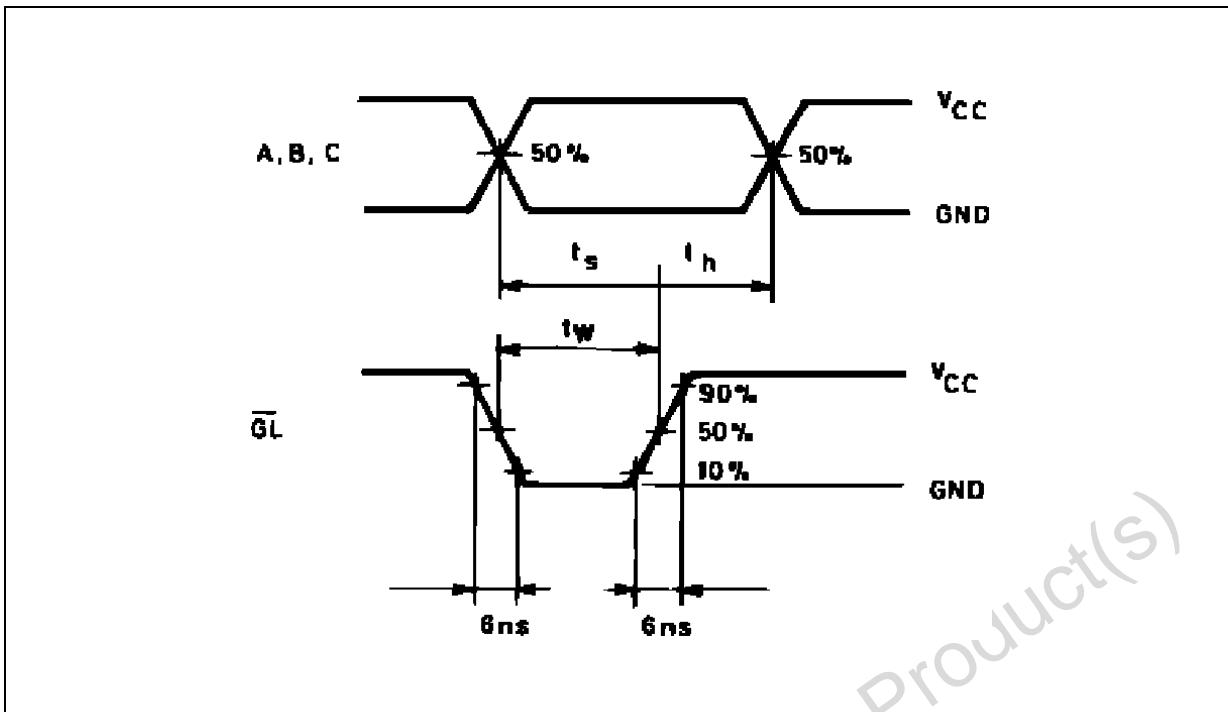
TEST CIRCUIT



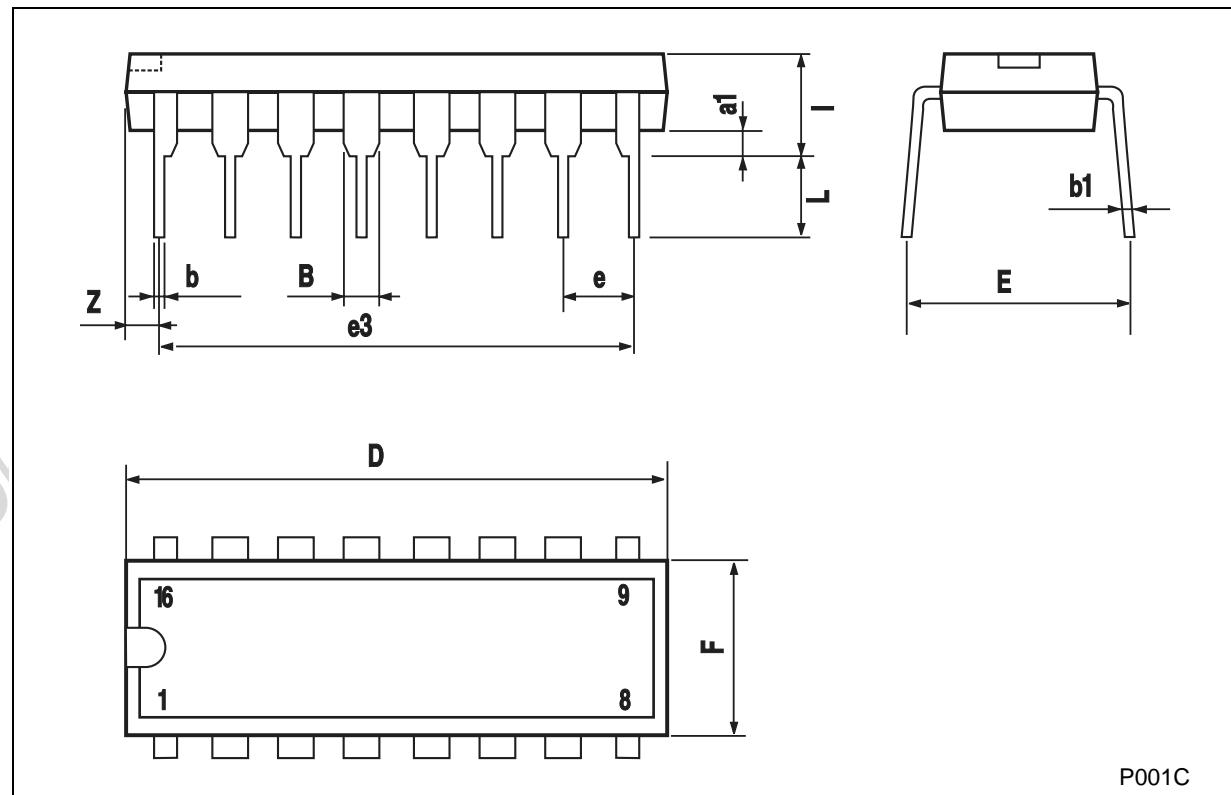
$C_L = 50\text{pF}$  or equivalent (includes jig and probe capacitance)  
 $R_T = Z_{\text{OUT}}$  of pulse generator (typically  $50\Omega$ )

WAVEFORM 1: PROPAGATION DELAY TIME (f=1MHz; 50% duty cycle)



WAVEFORM 2: SETUP AND HOLD TIME, MINIMUM PULSE WIDTH ( $\overline{GL}$ ) (f=1MHz; 50% duty cycle)

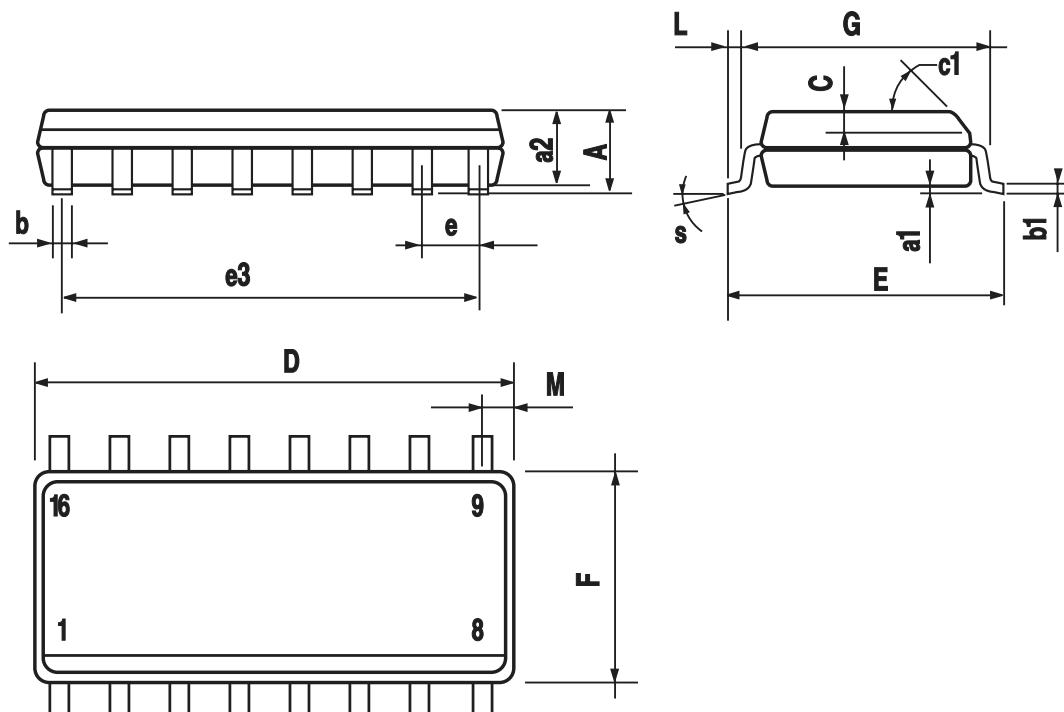
Plastic DIP-16 (0.25) MECHANICAL DATA						
DIM.	mm.			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
a1	0.51			0.020		
B	0.77		1.65	0.030		0.065
b		0.5			0.020	
b1		0.25			0.010	
D			20			0.787
E		8.5			0.335	
e		2.54			0.100	
e3		17.78			0.700	
F			7.1			0.280
I			5.1			0.201
L		3.3			0.130	
Z			1.27			0.050



P001C

## SO-16 MECHANICAL DATA

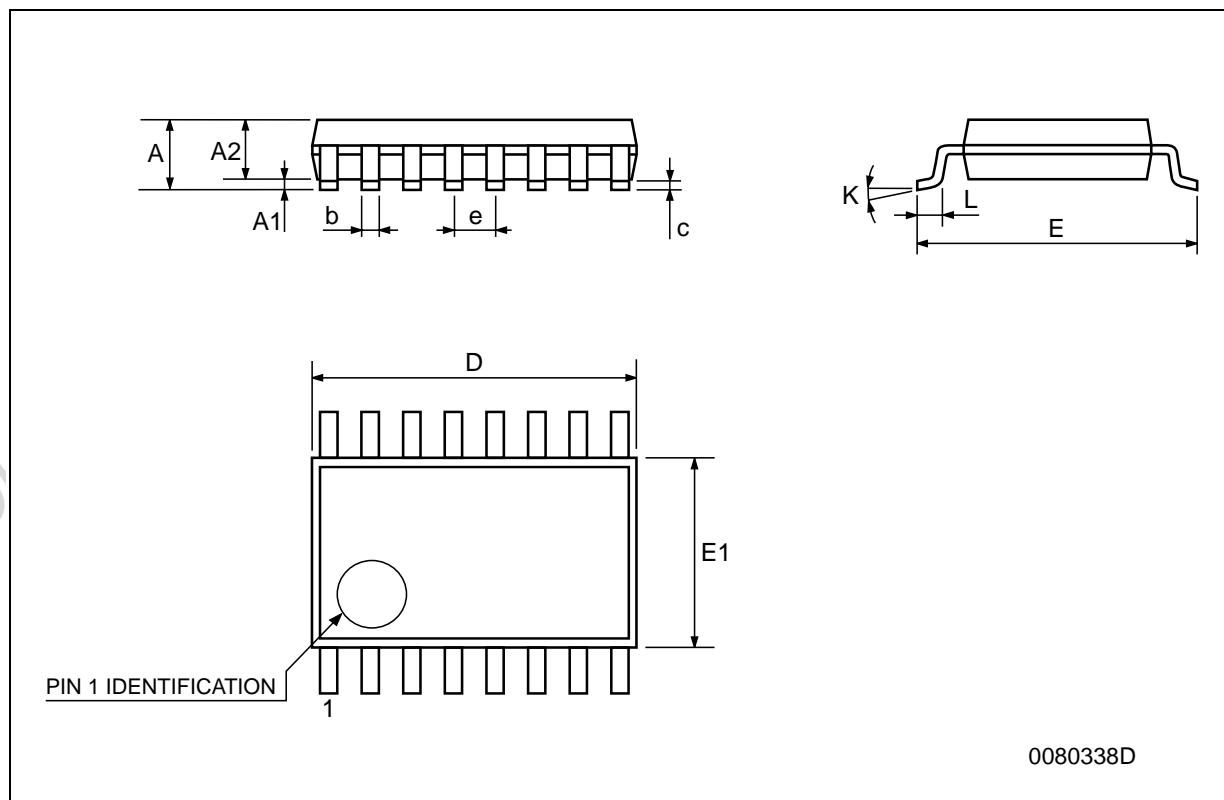
DIM.	mm.			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A			1.75			0.068
a1	0.1		0.2	0.003		0.007
a2			1.65			0.064
b	0.35		0.46	0.013		0.018
b1	0.19		0.25	0.007		0.010
C		0.5			0.019	
c1		45° (typ.)				
D	9.8		10	0.385		0.393
E	5.8		6.2	0.228		0.244
e		1.27			0.050	
e3		8.89			0.350	
F	3.8		4.0	0.149		0.157
G	4.6		5.3	0.181		0.208
L	0.5		1.27	0.019		0.050
M			0.62			0.024
S		8° (max.)				



PO13H

## TSSOP16 MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A			1.2			0.047
A1	0.05		0.15	0.002	0.004	0.006
A2	0.8	1	1.05	0.031	0.039	0.041
b	0.19		0.30	0.007		0.012
c	0.09		0.20	0.004		0.0089
D	4.9	5	5.1	0.193	0.197	0.201
E	6.2	6.4	6.6	0.244	0.252	0.260
E1	4.3	4.4	4.48	0.169	0.173	0.176
e		0.65 BSC			0.0256 BSC	
K	0°		8°	0°		8°
L	0.45	0.60	0.75	0.018	0.024	0.030



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